



Test report No. : 10443993H-A-R1  
Page : 1 of 17  
Issued date : October 17, 2014  
Revised date : October 28, 2014  
FCC ID : WAZSKE45A01

# **RADIO TEST REPORT**


**Test Report No. : 10443993H-A-R1**

**Applicant** : Mitsubishi Electric Corporation Himeji works  
**Type of Equipment** : Smart Keyless System (Smart Unit)  
**Model No.** : SKE45A-01  
**FCC ID** : WAZSKE45A01  
**Test regulation** : FCC Part 15 Subpart C: 2014  
**Test Result** : Complied

1. This test report shall not be reproduced in full or partial, without the written approval of UL Japan, Inc.
2. The results in this report apply only to the sample tested.
3. This sample tested is in compliance with above regulation.
4. The test results in this report are traceable to the national or international standards.
5. This test report must not be used by the customer to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the Federal Government.
6. This report is a revised version of 10443993H-A. 10443993H-A is replaced with this report.

**Date of test:** September 27, 2014

**Representative test engineer:**

  
Takumi Shimada  
Engineer  
Consumer Technology Division

**Approved by:**

  
Masanori Nishiyama  
Manager  
Consumer Technology Division



NVLAP LAB CODE: 200572-0

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\*As for the range of Accreditation in NVLAP, you may refer to the WEB address,  
<http://www.ul.com/japan/jpn/pages/services/emc/about/mark1/index.jsp#nvlap>

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## **SECTION 1: Customer information**

Company Name	:	Mitsubishi Electric Corporation Himeji works
Address	:	840 Chiyoda-machi Himeji Hyogo, 670-8677, Japan
Telephone Number	:	+81-79-298-7363
Facsimile Number	:	+81-79-298-9929
Contact Person	:	Shinichi Furuta

## **SECTION 2: Equipment under test (E.U.T.)**

### **2.1 Identification of E.U.T.**

Type of Equipment	:	Smart Keyless System (Smart Unit)
Model No.	:	SKE45A-01
Serial No.	:	Refer to Section 4, Clause 4.2
Rating	:	DC12.0V
Receipt Date of Sample	:	September 24, 2014
Country of Mass-production	:	Japan
Condition of EUT	:	Production prototype (Not for Sale: This sample is equivalent to mass-produced items.)
Modification of EUT	:	No Modification by the test lab

### **2.2 Product Description**

Model No: SKE45A-01 (referred to as the EUT in this report) is the Smart Keyless System (Smart Unit).  
The clock frequency of EUT is 10 MHz (CPU) and 29.509394MHz (RF receiving IC).

### **Radio Specification**

#### **LF Part**

Equipment Type	:	Transmitter
Type of modulation	:	ASK
Frequency of operation	:	125kHz
Other clock frequency	:	10MHz
Antenna Type	:	Inductive
Method of Frequency Generation	:	Crystal
Operating voltage (inner)	:	DC +5.0V

#### **RF Part \***

Type of Receiver	:	Receiver
Frequency of operation	:	315MHz
Other clock frequency	:	29.509394MHz
Intermediate frequency	:	220kHz
Antenna Type	:	Bar Antenna
Method of Frequency Generation	:	Crystal
Operating voltage (inner)	:	DC +5.0V

\* EUT also has this function. Please refer to No. 10443993H-C-R1 (FCC15B).

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## SECTION 3: Test specification, procedures & results

### 3.1 Test Specification

Test Specification : FCC Part 15 Subpart C: 2014, final revised on August 15, 2014 and effective October 14, 2014

Title : FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators  
Section 15.207 Conducted Emission  
Section 15.209 Radiated emission limits, general requirements

\* The revision on August 15, 2014 does not affect the test specification applied to the EUT.

#### FCC 15.31 (e)

This test was performed with the New Battery (DC 12V) and the constant voltage was supplied to this EUT during the tests. Therefore, this EUT complies with the requirement.

#### FCC Part 15.203 Antenna requirement

It is impossible for end users to replace the antenna, because the antenna is mounted inside of the EUT. Therefore, the equipment complies with the antenna requirement of Section 15.203.

### 3.2 Procedures and results

No.	Item	Test Procedure	Specification	Remarks	Deviation	Worst margin	Results
1	Conducted Emission	<FCC> ANSI C63.4:2003 7. AC powerline conducted emission measurements <IC> RSS-Gen 7.2.4	<FCC> Section 15.207 <IC> RSS-Gen 7.2.4	-	N/A	N/A	N/A *1)
2	Electric Field Strength of Fundamental Emission	<FCC> ANSI C63.4:2003 13. Measurement of intentional radiators <IC> RSS-Gen 4.8, 4.11	<FCC> Section 15.209 <IC> RSS-210 2.5.1 RSS-Gen 7.2.5	Radiated	N/A	8.1dB 0.12500MHz, AV (PK with Duty factor)	Complied
3	Electric Field Strength of Spurious Emission	<FCC> ANSI C63.4:2003 13. Measurement of intentional radiators <IC> RSS-Gen 4.9, 4.11	<FCC> Section 15.209 <IC> RSS-210 2.5.1 RSS-Gen 7.2.5	Radiated	N/A	20.0dB 78.505MHz, QP Vertical	Complied
4	-26dB Bandwidth	<FCC> ANSI C63.4:2003 13. Measurement of intentional radiators <IC> -	<FCC> Reference data <IC> -	Radiated	N/A	N/A	N/A

Note: UL Japan, Inc.'s EMI Work Procedures No. 13-EM-W0420 and 13-EM-W0422.

\*1) The test is not applicable since the EUT is not the device that is designed to be connected to the public utility (AC) power line.

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### 3.3 Addition to standard

No.	Item	Test Procedure	Specification	Remarks	Deviation	Worst margin	Results
1	99% Occupied Band Width	RSS-Gen 4.6.1	RSS-Gen 4.6.1	Radiated	N/A	N/A	N/A

Other than above, no addition, exclusion nor deviation has been made from the standard.

### 3.4 Uncertainty

#### EMI

The following uncertainties have been calculated to provide a confidence level of 95% using a coverage factor k=2.

Test room (semi-anechoic chamber)	Radiated emission						
	(3m*)(+dB)				(1m*)(+dB)		(0.5m*)(+dB)
	9kHz -30MHz	30MHz -300MHz	300MHz -1GHz	1GHz -10GHz	10GHz -18GHz	18GHz -26.5GHz	26.5GHz -40GHz
No.1	4.0dB	5.1dB	5.0dB	5.1dB	6.0dB	4.9dB	4.3dB
No.2	3.9dB	5.2dB	5.0dB	4.9dB	5.9dB	4.7dB	4.2dB
No.3	4.3dB	5.1dB	5.2dB	5.2dB	6.0dB	4.8dB	4.2dB
No.4	4.6dB	5.2dB	5.0dB	5.2dB	6.0dB	5.7dB	4.2dB

\*3m/1m/0.5m = Measurement distance

#### Radiated emission test (3m)

The data listed in this test report has enough margin, more than the site margin.

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### 3.5 Test Location

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	IC Registration Number	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms
No.1 semi-anechoic chamber	2973C-1	19.2 x 11.2 x 7.7m	7.0 x 6.0m	No.1 Power source room
No.2 semi-anechoic chamber	2973C-2	7.5 x 5.8 x 5.2m	4.0 x 4.0m	-
No.3 semi-anechoic chamber	2973C-3	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.3 Preparation room
No.3 shielded room	-	4.0 x 6.0 x 2.7m	N/A	-
No.4 semi-anechoic chamber	2973C-4	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.4 Preparation room
No.4 shielded room	-	4.0 x 6.0 x 2.7m	N/A	-
No.5 semi-anechoic chamber	-	6.0 x 6.0 x 3.9m	6.0 x 6.0m	-
No.6 shielded room	-	4.0 x 4.5 x 2.7m	4.0 x 4.5 m	-
No.6 measurement room	-	4.75 x 5.4 x 3.0m	4.75 x 4.15 m	-
No.7 shielded room	-	4.7 x 7.5 x 2.7m	4.7 x 7.5m	-
No.8 measurement room	-	3.1 x 5.0 x 2.7m	N/A	-
No.9 measurement room	-	8.0 x 4.6 x 2.8m	2.4 x 2.4m	-
No.11 measurement room	-	6.2 x 4.7 x 3.0m	4.8 x 4.6m	-

\* Size of vertical conducting plane (for Conducted Emission test) : 2.0 x 2.0m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

### 3.6 Data of EMI, Test instruments, and Test set up

Refer to APPENDIX.

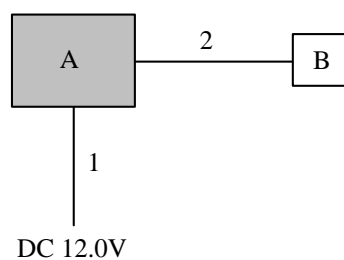
## SECTION 4: Operation of E.U.T. during testing

### 4.1 Operating Modes

The mode is used : Transmitting mode (125kHz)

Justification : The system was configured in typical fashion (as a customer would normally use it) for testing.

### 4.2 Configuration and peripherals



\*Cabling and setup were taken into consideration and test data was taken under worse case conditions.

#### Description of EUT and Support equipment

No.	Item	Model number	Serial number	Manufacturer	Remark
A	Smart Keyless System (Smart Unit)	SKE45A-01	20140922-F2(No.7)	Mitsubishi Electric Corporation Himeji works	EUT
B	Switch Box 1	-	No.17	Mitsubishi Electric Corporation Himeji works	-

#### List of cables used

No.	Name	Length (m)	Shield		Remarks
			Cable	Connector	
1	DC Cable	1.5	Unshielded	Unshielded	-
2	Signal Cable	1.5	Unshielded	Unshielded	-

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## **SECTION 5: Radiated emission (Fundamental and Spurious Emission)**

### **Test Procedure**

The Radiated Electric Field Strength intensity has been measured on No.4 semi anechoic chamber with a ground plane and at a distance of 3m.

Frequency : From 9kHz to 30MHz at distance 3m

The EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity.

The measurements were performed for vertical polarization (antenna angle: 0deg., 45deg., 90deg., 135 deg., and 180deg.)

and horizontal polarization.

\*Refer to Figure 1 about Direction of the Loop Antenna.

Frequency : From 30MHz to 1GHz at distance 3m

The measuring antenna height varied between 1 and 4m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity.

The measurements were performed for both vertical and horizontal antenna polarization.

Although these tests were performed other than open field test site, adequate comparison measurements were confirmed against 30 m open field test site. Therefore sufficient tests were made to demonstrate that the alternative site produces results that correlate with the ones of tests made in an open field based on KDB 937606.

Measurements were performed with a QP and PK detector.

The radiated emission measurements were made with the following detector function of the test receiver (below 1GHz).

	From 9kHz to 90kHz and From 110kHz to 150kHz	From 90kHz to 110kHz	From 150kHz to 490kHz	From 490kHz to 30MHz	From 30MHz to 1GHz
Detector Type	PK/AV	QP	PK/AV	QP	QP
IF Bandwidth	200Hz	200Hz	9kHz	9kHz	120kHz
Distance factor *1)	-80dB	-80dB	-80dB	-40dB	-

\*1) -80dB =  $40 \times \log (3\text{m}/300\text{m})$

-40dB =  $40 \times \log (3\text{m}/30\text{m})$

- The carrier level and noise levels were measured at each position of all three axes X, Y and Z, and the position that has the maximum noise was determined.

With the position, the noise levels of all the frequencies were measured.

**Test data** : **APPENDIX 1**

**Test result** : **Pass**

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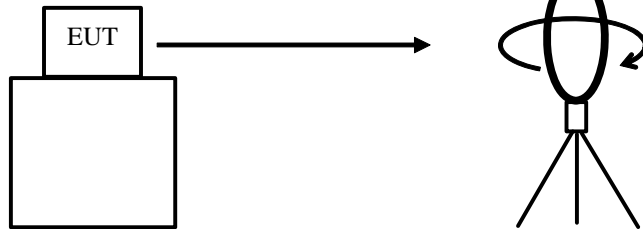
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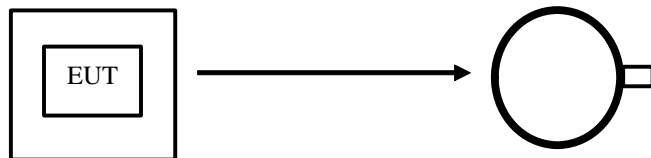
Facsimile : +81 596 24 8124

**Figure 1: Direction of the Loop Antenna**

*Side View (Vertical)*

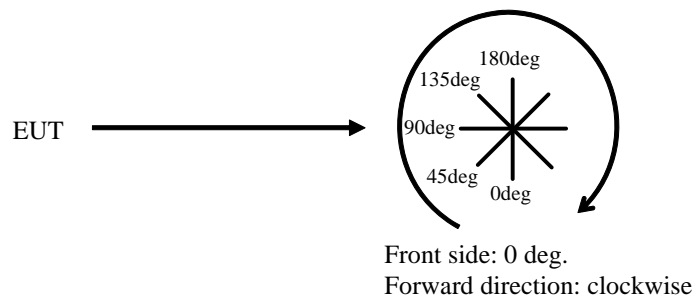


.....  
*Top View (Horizontal)*



Antenna was not rotated.

.....  
*Top View (Vertical)*



## **SECTION 6: -26dB Bandwidth**

### **Test Procedure**

The measurement was performed in the antenna height to gain the maximum of Electric field strength.

Test data	: APPENDIX 1
Test result	: Pass

## **SECTION 7: 99% Occupied Bandwidth**

### **Test Procedure**

The measurement was performed in the antenna height to gain the maximum of Electric field strength.

Test data	: APPENDIX 1
Test result	: Pass

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## APPENDIX 1: Data of EMI test

### Radiated Emission below 30MHz (Fundamental and Spurious Emission)

Test place Ise EMC Lab. No.4 Semi Anechoic Chamber  
Report No. 10443993H  
Date 09/27/2014  
Temperature/ Humidity 23 deg. C / 54% RH  
Engineer Takumi Shimada  
Mode Tx 125kHz

#### PK or QP

Ant Deg [deg]	Frequency [MHz]	Detector	Reading [dBuV]	Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
0	0.12500	PK	103.6	20.0	-73.9	32.2	-	17.5	45.6	28.1	Fundamental
0	0.25000	PK	74.5	19.9	-73.9	32.1	-	-11.6	39.6	51.2	
0	0.37500	PK	40.8	19.8	-73.9	32.1	-	-45.4	36.1	81.5	
0	0.50000	QP	37.2	19.8	-33.8	32.1	-	-8.9	33.6	42.5	
0	0.62500	QP	55.4	19.8	-33.8	32.1	-	9.3	31.7	22.4	
0	0.75000	QP	33.8	19.8	-33.8	32.1	-	-12.3	30.1	42.4	
0	0.87500	QP	49.5	19.8	-33.8	32.1	-	3.4	28.7	25.3	
0	1.00000	QP	32.6	19.8	-33.8	32.1	-	-13.5	27.6	41.1	
0	1.12500	QP	44.2	19.8	-33.8	32.1	-	-1.9	26.5	28.4	
0	1.25000	QP	32.0	19.8	-33.8	32.1	-	-14.1	25.6	39.7	

Result = Reading + Ant Factor + Loss (Cable + Attenuator + Filter + D.Factor) - Gain(Amplifier)

#### AV (PK with Duty factor)

Ant Deg [deg]	Frequency [MHz]	Detector	Reading [dBuV]	Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
0	0.12500	PK	103.6	20.0	-73.9	32.2	0.0	17.5	25.6	8.1	
0	0.25000	PK	74.5	19.9	-73.9	32.1	0.0	-11.6	19.6	31.2	
0	0.37500	PK	40.8	19.8	-73.9	32.1	0.0	-45.4	16.1	61.5	

Result = Reading + Ant Factor + Loss (Cable + Attenuator + Filter + D.Factor) - Gain(Amplifier) + Duty factor \*

\* Since the peak emission result satisfied the average limit, duty factor was omitted.

Although Duty of this product was 100% or less, the result of AV (PK with Duty factor) was calculated by applying Duty 100% as worst.

#### Result of the fundamental emission at 3m without Distance factor

##### PK

Ant Deg [deg]	Frequency [MHz]	Detector	Reading [dBuV]	Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
0	0.12500	PK	103.6	20.0	6.1	32.2	-	97.5	-	-	Fundamental

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter) - Gain(Amplifier)

\* All spurious emissions lower than this result.

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## Radiated Emission above 30MHz (Spurious Emission)

### DATA OF RADIATED EMISSION TEST

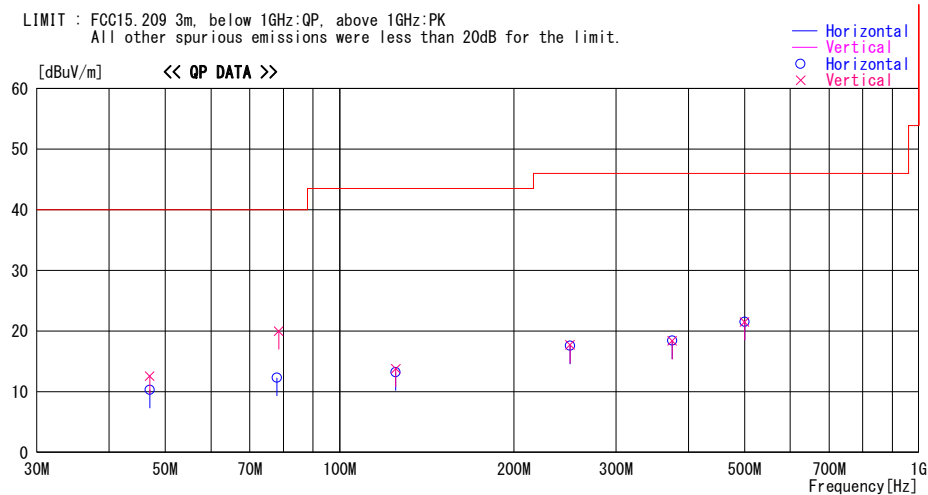
UL Japan, Inc. Ise EMC Lab. No.4 Semi Anechoic Chamber  
Date : 2014/09/27

Report No. : 10443993H

Temp./Humi. : 23deg. C / 54% RH  
Engineer : Takumi Shimada

Mode / Remarks : Tx 125kHz Worst axis (Hori:Z /Vert:Z)

LIMIT : FCC15.209 3m, below 1GHz:QP, above 1GHz:PK  
All other spurious emissions were less than 20dB for the limit.



Frequency	Reading	DET	Antenna Factor	Loss & Gain	Level	Angle	Height	Polar.	Limit	Margin	Comment
[MHz]	[dBuV]		[dB/m]	[dB]	[dBuV/m]	[Deg]	[cm]		[dBuV/m]	[dB]	
47.003	23.1	QP	11.9	-24.7	10.3	0	300	Hori.	40.0	29.7	
47.003	25.4	QP	11.9	-24.7	12.6	204	100	Vert.	40.0	27.4	
78.000	30.0	QP	6.5	-24.2	12.3	326	216	Hori.	40.0	27.7	
78.505	37.7	QP	6.5	-24.2	20.0	97	100	Vert.	40.0	20.0	
125.000	23.4	QP	13.4	-23.6	13.2	0	300	Hori.	43.5	30.3	
125.000	24.0	QP	13.4	-23.6	13.8	359	100	Vert.	43.5	29.7	
250.000	22.7	QP	17.3	-22.4	17.6	359	300	Hori.	46.0	28.4	
250.000	22.8	QP	17.3	-22.4	17.7	359	100	Vert.	46.0	28.3	
375.000	22.7	QP	17.2	-21.5	18.4	0	100	Hori.	46.0	27.6	
375.000	22.7	QP	17.2	-21.5	18.4	0	100	Vert.	46.0	27.6	
500.000	23.1	QP	19.2	-20.8	21.5	0	100	Hori.	46.0	24.5	
500.000	23.1	QP	19.2	-20.8	21.5	0	100	Vert.	46.0	24.5	

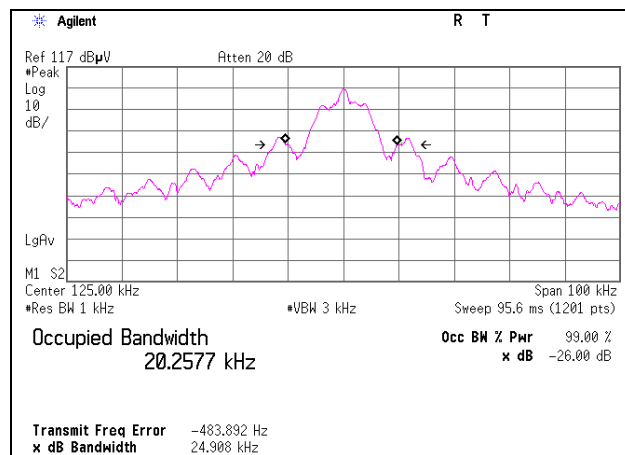
CHART:WITH FACTOR ANT TYPE: -30MHz:LOOP, 30-300MHz:BICONICAL, 300MHz-1000MHz:LOGPERIODIC, 1000MHz-:HORN  
CALCULATION:RESULT = READING + ANT FACTOR + LOSS (CABLE + ATTEN. - GAIN(AMP))

\*The test result is rounded off to one or two decimal places, so some differences might be observed.

### -26dB Bandwidth and 99% Occupied Bandwidth

Test place : Ise EMC Lab. No.4 Semi Anechoic Chamber  
Report No. : 10443993H  
Date : 09/27/2014  
Temperature/ Humidity : 23 deg. C / 54% RH  
Engineer : Takumi Shimada  
Mode : Tx 125kHz

Mode	Frequency [kHz]	-26dB Bandwidth [kHz]	99% Occupied Bandwidth [kHz]
Tx 125kHz	125	24.908	20.258



## APPENDIX 2: Test instruments

### EMI test equipment

Control No.	Instrument	Manufacturer	Model No	Serial No	Test Item	Calibration Date * Interval(month)
MAEC-04	Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 3m	DA-10005	RE	2014/02/28 * 12
MOS-15	Thermo-Hygrometer	Custom	CTH-180	1501	RE	2014/02/20 * 12
MJM-22	Measure	ASKUL	-	-	RE	-
COTS-MEMI	EMI measurement program	TSJ	TEPTO-DV	-	RE	-
MTR-01	Test Receiver	Rohde & Schwarz	ESI40	100084	RE	2013/11/12 * 12
MBA-05	Biconical Antenna	Schwarzbeck	BBA9106	1302	RE	2013/11/24 * 12
MLA-08	Logperiodic Antenna	Schwarzbeck	UKLP9140-A	N/A	RE	2013/11/24 * 12
MCC-50	Coaxial Cable	UL Japan	-	-	RE	2014/06/02 * 12
MAT-68	Attenuator	Anritsu	MP721B	6200961025	RE	2013/11/26 * 12
MPA-14	Pre Amplifier	SONOMA INSTRUMENT	310	260833	RE	2014/03/14 * 12
MLPA-01	Loop Antenna	Rohde & Schwarz	HFH2-Z2	100017	RE	2013/10/30 * 12
MCC-113	Coaxial cable	Fujikura/Suhner/TSJ	5D-2W(10m)/ SFM141(5m)/ 421-010(1m)/ sucoform141-PE(1m)/ RFM-E121(Switcher)	-/04178	RE	2014/07/15 * 12
MCC-143	Coaxial Cable	UL Japan	-	-	RE	2014/07/28 * 12
MSA-03	Spectrum Analyzer	Agilent	E4448A	MY4402035 7	RE	2014/04/08 * 12

The expiration date of the calibration is the end of the expired month.

All equipment is calibrated with valid calibrations. Each measurement data is traceable to the national or international standards.

As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.

Test Item:

RE: Spurious emission

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